## Supplementary Information

## Highly crystalline, small size, monodisperse $\alpha-$ NiS nanocrystal ink as an efficient counter electrode for dye-sensitized solar cells

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Figure S1 Top (a) and cross-sectional (b) SEM images of the densely packed $\mathrm{E}_{\text {Nis-300 }}$.

Table S1. The FWHM values with different planes of NiS-250 and NiS-300.

| Different planes | $(100)$ | $(101)$ | $(102)$ | $(110)$ |
| :--- | :--- | :--- | :--- | :--- |
| FWHM (NiS-250) | 0.833 | 0.887 | 1.109 | 0.890 |
| FWHM (NiS-300) | 0.624 | 0.632 | 0.837 | 0.684 |



Figure S2 The magnified XRD patterns of NiS-250 (a), NiS-300 (b), respectively.


Figure S3 XPS of NiS-250 and NiS-320 for Ni 2 p region (a) and S 2p region (b), respectively.


Figure S4 Dynamic light scattering measurements of NiS-300.


Figure S5 SAED images of the NiS-250 (a) and NiS-320 (b).


Figure S6 TEM image of NiS-250 (a) and NiS-320 (b), the HRTEM of NiS-320(c).


Figure S7 SEM image of bulk NiS with large size and corresponding EDS.


Figure S8 Current-voltage characteristics of the DSSCs with C $_{\text {bulk-Nis }}$ under one sun illumination.


Figure S9 Twenty consecutive CV curves for the $\mathrm{E}_{\mathrm{Pt}}$ at a scan rate of $25 \mathrm{mV} \mathrm{s}^{-1}$.


Figure S10 equivalent circuit used to represent interfaces in dummy cells composed of two identical counter electrodes.


Figure S11 Work function map of NiS-250 (a) and NiS-320 (b).

